EcoSPARK[®] 2 N-Channel Ignition IGBT

335 mJ, 400 V

FGD3440G2-F085V

Features

- SCIS Energy = 335 mJ at $T_J = 25^{\circ}C$
- Logic Level Gate Drive
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Application

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	400	V
BV _{ECS}	Emitter to Collector Voltage – Reverse Battery Condition (I _C = 10 mA)	28	V
E _{SCIS25}	Self Clamping Inductive Switching Energy (Note 1)	335	mJ
E _{SCIS150}	Self Clamping Inductive Switching Energy (Note 2)	195	mJ
I _{C25}	Collector Current Continuous at V_{GE} = 4.0 V, T_{C} = 25°C	26.9	A
I _{C110}	Collector Current Continuous at V_{GE} = 4.0 V, T_{C} = 110°C	25	A
V _{GEM}	Gate to Emitter Voltage Continuous	±10	V
PD	Power Dissipation Total, $T_C = 25^{\circ}C$	166	W
	Power Dissipation Derating, $T_C > 25^{\circ}C$	1.1	W/°C
TJ	Operating Junction and Storage Temperature	-40 to +175	°C
T _{STG}	Storage Junction Temperature Range	-40 to +175	°C
TL	Max. Lead Temperature for Soldering (Leads at 1.6 mm from case for 10 s)	300	°C
Т _{РКG}	Max. Lead Temperature for Soldering (Package Body for 10 s)	260	°C
ESD	HBM–Electrostatic Discharge Voltage at 100 pF, 1500 Ω	4	kV

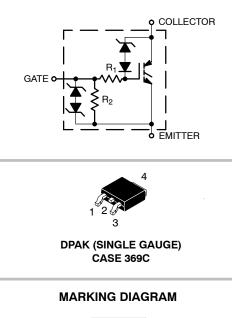
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

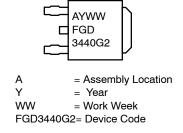
- Self clamped inductive Switching Energy (ESCIS25) of 335 mJ is based on the test conditions that is starting T_J = 25°C, L = 3 mHy, ISCIS = 15 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.
- Self Clamped inductive Switching Energy (ESCIS150) of 195 mJ is based on the test conditions that is starting T_J = 150°C, L = 3mHy, ISCIS = 11.4 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.



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ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

THERMAL RESISTANCE RATINGS

Characteristic	Symbol	Max	Units
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	0.9	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
FF CHARA	ACTERISTICS						
BV _{CER}	Collector to Emitter Breakdown Voltage	$\begin{array}{l} I_{CE} = 2 \text{ mA, } V_{GE} = 0 \text{ V,} \\ R_{GE} = 1 \text{ k}\Omega, T_J = -40 \text{ to } 150^\circ\text{C} \end{array}$		370	400	430	V
BV _{CES}	Collector to Emitter Breakdown Voltage	$I_{CE} = 10 \text{ mA}, V_{GE} = 0 \text{ V}, R_{GE} = 0, T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		390	420	450	V
BV _{ECS}	Emitter to Collector Breakdown Voltage	I_{CE} = -20 mA, V_{GE} = 0 V, T_{J} = 25°C		28	-	-	V
BV_{GES}	Gate to Emitter Breakdown Voltage	I _{GES} = ±2 mA		±12	±14	-	V
I _{CER}	Collector to Emitter Leakage Current	$V_{CE} = 250 V$ $T_{J} = 25^{\circ}C$		-	-	25	μA
		R _{GE} = 1 kΩ	T _J = 150°C	-	-	1	mA
I _{ECS}	Emitter to Collector Leakage Current	V _{EC} = 24 V	$T_J = 25^{\circ}C$	-	-	1	mA
			$T_J = 150^{\circ}C$	-	-	40	
R ₁	Series Gate Resistance		-	-	120	-	Ω
R ₂	Gate to Emitter Resistance			10K	_	30K	Ω

V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I_{CE} = 6 A, V_{GE} = 4 V, T_{J} = 25°C	-	1.1	1.2	V
		I_{CE} = 10 A, V_{GE} = 4.5 V, T_{J} = 150°C	_	1.3	1.45	
		I_{CE} = 15 A, $V_{GE}~$ = 4.5 V, T_{J} = 150°C	-	1.6	1.75	

DYNAMIC CHARACTERISTICS

Q _{G(ON)}	Gate Charge	$I_{CE} = 10 \text{ A}, V_{CE} = 12 \text{ V}, V_{GE} = 5 \text{ V}$		-	24	-	nC
V _{GE(TH)}	Gate to Emitter Threshold Voltage	$I_{CE} = 1 \text{ mA}$	$T_J = 25^{\circ}C$	1.3	1.7	2.2	V
		V _{CE} = V _{GE}	$T_J = 150^{\circ}C$	0.75	1.2	1.8	
V _{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12 V, I _{CE} = 10 A		-	2.8	-	V

SWITCHING CHARACTERISTICS

t _{d(ON)R}	Current Turn-On Delay Time-Resistive	$V_{CE} = 14 \text{ V}, \text{ R}_{\text{L}} = 1 \Omega, \text{ V}_{\text{GE}} = 5 \text{ V},$	-	1.0	4	μs
t _{rR}	Current Rise Time-Resistive	R _G = 1 KΩ, T _J = 25°C	-	2.0	7	
t _{d(OFF)L}	Current Turn-Off Delay Time-Inductive	$V_{CE} = 300 \text{ V}, \text{ L} = 1 \text{ mH}, \text{ V}_{GE} = 5 \text{ V},$	-	5.3	10	
t _{fL}	Current Fall Time-Inductive	R _G = 1KΩ, I _{CE} = 6.5 A, T _J = 25°C	-	2.3	15	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Diameter	Tape Width	Qty⁺
FGD3440G2	FGD3440G2-F085V	DPAK (Pb-Free)	330 mm	16 mm	2500

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

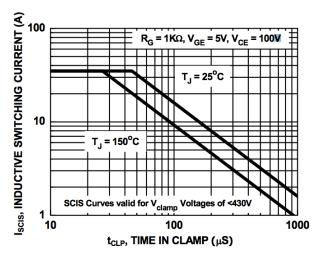


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

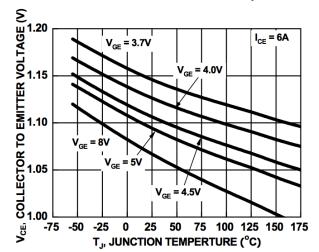
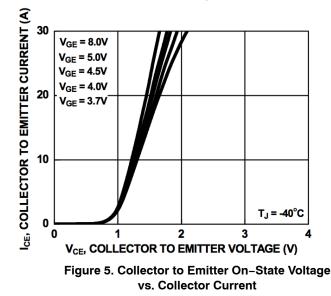
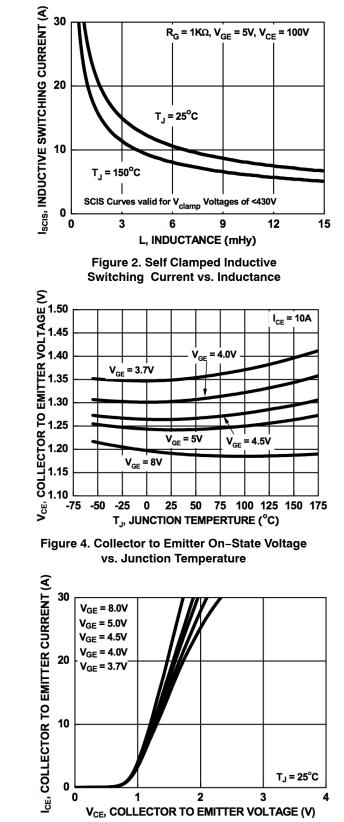
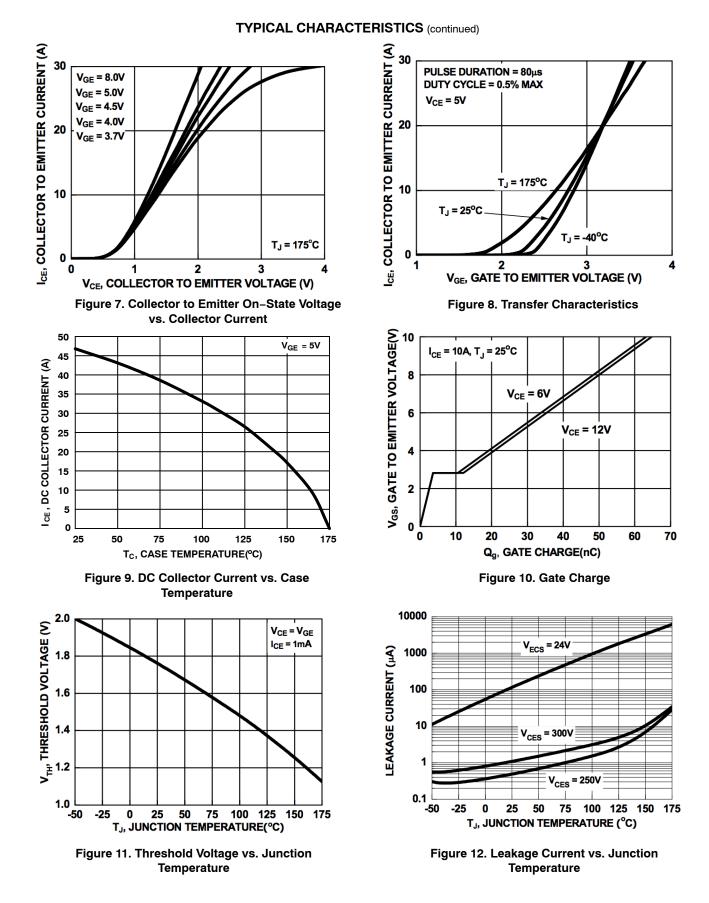


Figure 3. Collector to Emitter On–State Voltage vs. Junction Temperature









TYPICAL CHARACTERISTICS (continued)

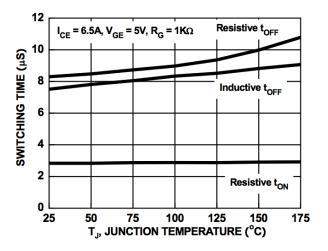
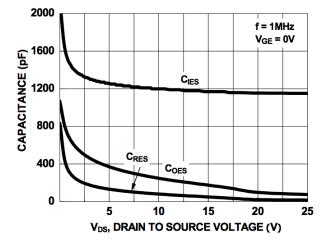


Figure 13. Switching Time vs. Junction Temperature





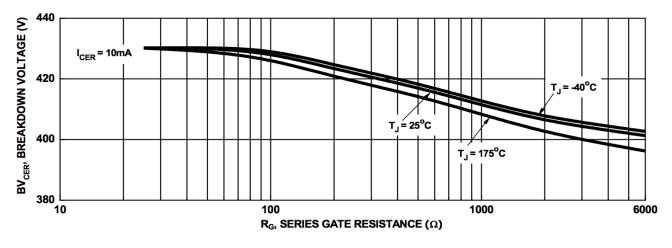


Figure 15. Break Down Voltage vs. Series Resistance

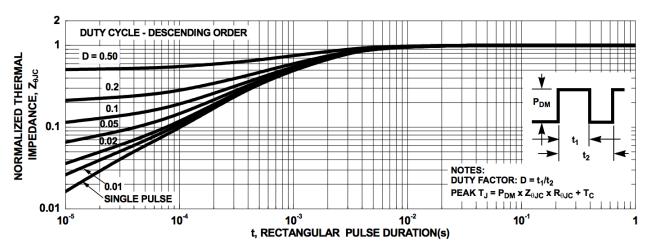


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

TEST CIRCUIT AND WAVEFORMS

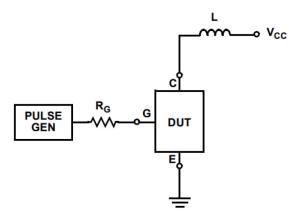


Figure 17. Inductive Switching Test Circuit

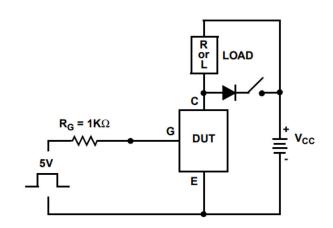


Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

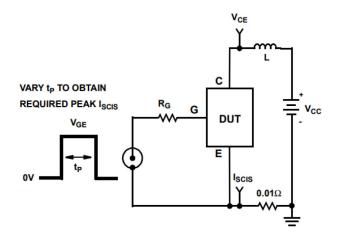


Figure 19. Energy Test Circuit

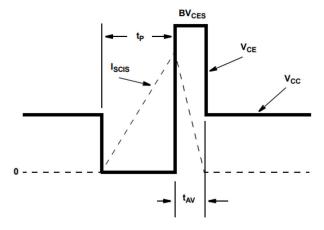


Figure 20. Energy Waveforms

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